## Search Notes



## Application/Control No.

MICHAEL Y. WON

Applicant(s)/Patent under Reexamination 10/743,787 MAEDA, TOSHIHIRO Art Unit

Examiner

2455

SEARCHED					
Class	Subclass	Date	Examiner		
709	221, 222, 223, 228	5/13/2010	MW		
715	736, 853	5/13/2010	MW		
		1			

	ERFERENC	DE OLARON	Г
Class	Subclass	Date	Examiner
709	223	5/13/2010	MW

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST: USPAT; USPG-PUB; DERWENT; EPO; JPO	5/13/2010	MW		
NPL SEARCH: IEEE	5/13/2010	MW		